



843.41106X00

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: K. ASAYAMA, et al.
Application No.: 10/051,056
Filed: January 22, 2002
For: SEMICONDUCTOR DEVICE, METHOD OF MEASURING
THE SAME, AND METHOD OF MANUFACTURING THE
SAME
Art Unit: 2829
Examiner: E. T. Pert

AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

August 26, 2003

Sir:

In response to the Office Action dated June 26, 2003, the period of response for which extension is requested by the attached Petition for Extension of Time, please amend the above-identified application as listed below and as set forth on the following pages:

Amendments to the claims

Remarks are included following the amendments.